

1. Description

BLG20T65FDLA is obtained by advanced Trench Field Stop (T-FS) technology which is characteristic with low $V_{CE(sat)}$, optimized switching performance and low gate charge Q_g . The IGBT is suitable device for BLDC, UPS, and low $V_{CE(sat)}$ applications.

KEY CHARACTERISTICS

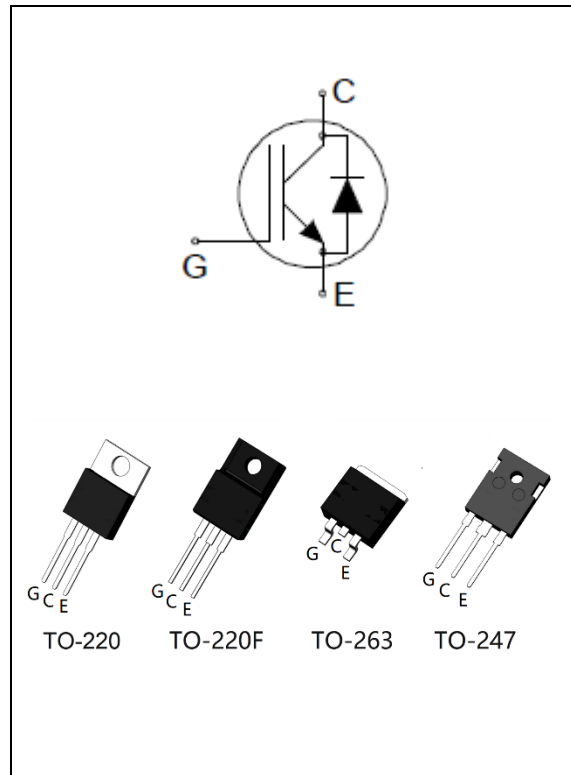
Parameter	Value	Unit
V_{CES}	650	V
I_C	20	A
$V_{CE(sat).typ}$	1.55	V

FEATURES

- Fast Switching
- LOW $V_{CE(sat)}$
- Positive temperature coefficient
- Very soft, fast recovery anti-parallel diode
- RoHS product

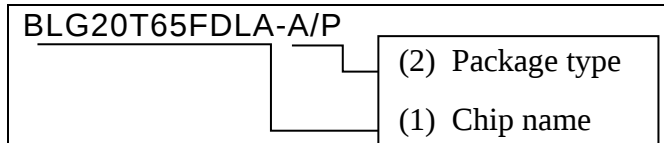
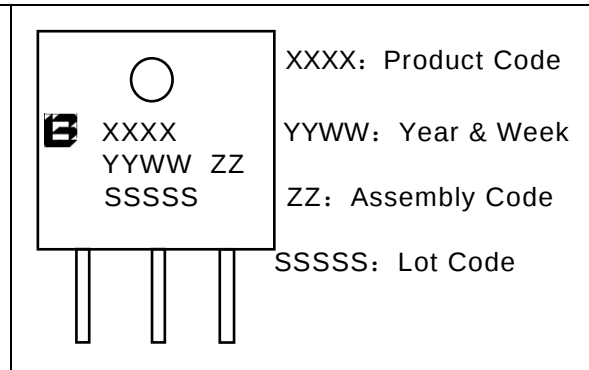
APPLICATIONS

- UPS
- Motor drives
- PFC
- Portable power station



ORDERING INFORMATION

Device Marking	Ordering Codes	Package	Product Code	Packing
20T65FDLA	BLG20T65FDLA-A	TO-220F	BLG20T65FDLA	Tube
	BLG20T65FDLA-P	TO-220		Tube
	BLG20T65FDLA-F	TO-247		Tube
	BLG20T65FDLA-B	TO-263		Reel

BLG20T65FDLA-A/P  (1) BLG20T65FDLA: 650V 20A (2) P:TO-220 A:TO-220F F:TO-247 B:TO-263	 XXXX: Product Code YYWW: Year & Week ZZ: Assembly Code SSSSS: Lot Code
--	---

2. ABSOLUTE RATINGS

Symbol	Parameter	TO-220/ TO263	TO- 220F	TO-247	Units
V_{CES}	Collector-Emitter Voltage	650	650	650	V
I_C	Collector Current @ $T_C=25^{\circ}\text{C}$	40	40	40	A
	Collector Current @ $T_C=100^{\circ}\text{C}$	20	20	20	A
I_{CM}	Pulsed Collector Current, tp limited by T_{Jmax}	80	80	80	A
I_F	Diode Continuous Forward Current @ $T_C=25^{\circ}\text{C}$	40	40	40	A
	Diode Continuous Forward Current @ $T_C=100^{\circ}\text{C}$	20	20	20	A
I_{FM}	Diode Maximum Forward Current, limited by T_{Jmax}	80	80	80	A
V_{GES}	Gate-Emitter Voltage	± 30	± 30	± 30	V
t_{SC}	Short circuit withstand time $V_{GE}=15\text{V}$, $V_{CC}\leq 400\text{V}$, Allowed number of short circuits<1000, Times between short circuits: $\geq 1.0\text{s}$, $T_J \leq 175^{\circ}\text{C}$	3.0			μs
P_D	Power Dissipation @ $T_C=25^{\circ}\text{C}$	136	39	300	W
T_{Jmax} , T_{stg}	Operating Junction and Storage Temperature Range	175, -55 to 175			$^{\circ}\text{C}$
T_L	Maximum Temperature for Soldering	260			$^{\circ}\text{C}$

3. Thermal characteristics

Symbol	Parameter	TO-220/ TO263	TO-220F	TO-247	Units
$R_{\theta JC}$	Junction-to-Case (IGBT)	1.1	3.6	0.5	$^{\circ}\text{C/W}$
$R_{\theta JC}$	Junction-to-Case (Diode)	2.2	4.4	0.8	$^{\circ}\text{C/W}$
$R_{\theta JA}$	Junction-to-Ambient	62.5	78	40	$^{\circ}\text{C/W}$

4. Electrical Characteristics

at $T_C = 25^{\circ}\text{C}$, unless otherwise specified

Static Characteristics

Symbol	Parameter	Test Conditions	Values			Units
			Min.	Typ.	Max.	
V_{CES}	Collector-Emitter Breakdown Voltage	$V_{GE} = 0\text{V}$, $I_C = 250\mu\text{A}$	650	--	--	V
$V_{CE(sat)}$	Collector-Emitter Saturation Voltage	$V_{GE} = 15\text{V}$, $I_C = 20\text{A}$ $T_J=25^{\circ}\text{C}$	--	1.55	1.95	V
		$T_J=125^{\circ}\text{C}$	--	1.80	--	
		$T_J=175^{\circ}\text{C}$	--	1.90	--	

$V_{GE(TH)}$	Gate Threshold Voltage	$V_{CE} = V_{GE}, I_C = 1mA$	5.0	5.8	6.5	V
V_F	Diode Forward Voltage	$I_F = 20A$ $T_J = 25^\circ C$ $T_J = 125^\circ C$ $T_J = 175^\circ C$	--	2.20 1.80 1.65	2.80 -- --	V
I_{CES}	Collector-Emitter Leakage Current	$V_{CE} = 650V$, $V_{GE} = 0V$	--	--	25	μA
$I_{GES(F)}$	Gate-Emitter Forward Leakage Current	$V_{GE} = +30V$	--	--	200	nA
$I_{GES(R)}$	Gate-Emitter Reverse Leakage Current	$V_{GE} = -30V$	--	--	-200	nA
Pulse width $tp \leq 300\mu s$, $\delta \leq 2\%$						

Dynamic Characteristics

Symbol	Parameter	Test Conditions	Values			Units
			Min.	Typ.	Max.	
C_{iss}	Input Capacitance	$V_{GE} = 0V$ $V_{CE} = 25V$ $f = 1.0MHz$	--	892	--	pF
C_{oss}	Output Capacitance		--	43	--	
C_{rss}	Reverse Transfer Capacitance		--	10	--	
Q_G	Gate charge	$V_{CC} = 520V$ $I_{CE} = 20A$ $V_{GE} = 15V$	--	44	--	nC
Q_{GE}	Gate-emitter charge		--	13	--	
Q_{GC}	Gate-collector charge		--	18	--	
$I_{C(SC)}$	Short circuit collector current Max.1000 short circuits, Times between short circuits: $\geq 1.0s$	$V_{GE} = 15.0V$, $V_{CC} \leq 400V$, $t_{sc} \leq 3\mu s$, $T_J \leq 175^\circ C$		110		A

IGBT Switching Characteristics, at $T_J = 25^\circ C$

Symbol	Parameter	Test Conditions	Values			Units
			Min.	Typ.	Max.	
$t_{d(on)}$	Turn-on Delay Time	$I_C = 20A$ $V_{CE} = 400V$ $V_{GE} = 15V$ $R_G = 5\Omega$ $T_J = 25^\circ C$ Inductive Load	--	12	--	ns
t_r	Rise Time		--	17	--	
$t_{d(off)}$	Turn-Off Delay Time		--	136	--	
t_f	Fall Time		--	36	--	
E_{on}	Turn-On Switching Loss		--	0.28	--	mJ
E_{off}	Turn-Off Switching Loss		--	0.28	--	
E_{ts}	Total Switching Loss		--	0.56	--	

IGBT Switching Characteristics, at $T_J=175^{\circ}\text{C}$

Symbol	Parameter	Test Conditions	Values			Units
			Min.	Typ.	Max.	
$t_{d(on)}$	Turn-on Delay Time	$I_C = 20\text{A}$ $V_{CE} = 400\text{V}$ $V_{GE} = 15\text{V}$ $R_G = 5\Omega$ $T_J = 175^{\circ}\text{C}$ Inductive Load	--	12	--	ns
t_r	Rise Time		--	17	--	
$t_{d(off)}$	Turn-Off Delay Time		--	158	--	
t_f	Fall Time		--	90	--	
E_{on}	Turn-On Switching Loss		--	0.44	--	mJ
E_{off}	Turn-Off Switching Loss		--	0.38	--	
E_{ts}	Total Switching Loss		--	0.82	--	

Diode Characteristics, at $T_J=25^{\circ}\text{C}$

Symbol	Parameter	Test Conditions	Values			Units
			Min.	Typ.	Max.	
T_{rr}	Reverse Recovery Time	$I_F = 10\text{A}$, $di/dt = 200\text{A}/\mu\text{s}$, $T_J = 25^{\circ}\text{C}$	--	74	--	ns
Q_{rr}	Reverse Recovery Charge		--	81	--	nC
I_{rrm}	Reverse Recovery Current		--	1.2	--	A
T_{rr}	Reverse Recovery Time	$I_F = 20\text{A}$, $di/dt = 200\text{A}/\mu\text{s}$, $T_J = 25^{\circ}\text{C}$	--	97	--	ns
Q_{rr}	Reverse Recovery Charge		--	109	--	nC
I_{rrm}	Reverse Recovery Current		--	1.8	--	A

Diode Characteristics, at $T_J=175^{\circ}\text{C}$

Symbol	Parameter	Test Conditions	Values			Units
			Min.	Typ.	Max.	
T_{rr}	Reverse Recovery Time	$I_F = 10\text{A}$, $di/dt = 200\text{A}/\mu\text{s}$, $T_J = 175^{\circ}\text{C}$	--	112	--	ns
Q_{rr}	Reverse Recovery Charge		--	632	--	nC
I_{rrm}	Reverse Recovery Current		--	2.9	--	A
T_{rr}	Reverse Recovery Time	$I_F = 20\text{A}$, $di/dt = 200\text{A}/\mu\text{s}$, $T_J = 175^{\circ}\text{C}$	--	147	--	ns
Q_{rr}	Reverse Recovery Charge		--	742	--	nC
I_{rrm}	Reverse Recovery Current		--	7.8	--	A

5. Characteristics Curves

Figure 1. Forward Bias Safe Operating Area for TO220/TO263

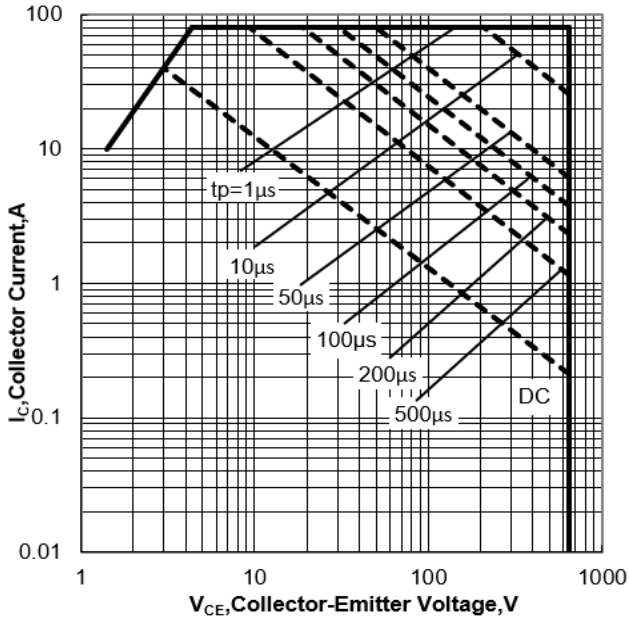


Figure 2. Forward Bias Safe Operating Area for TO220F

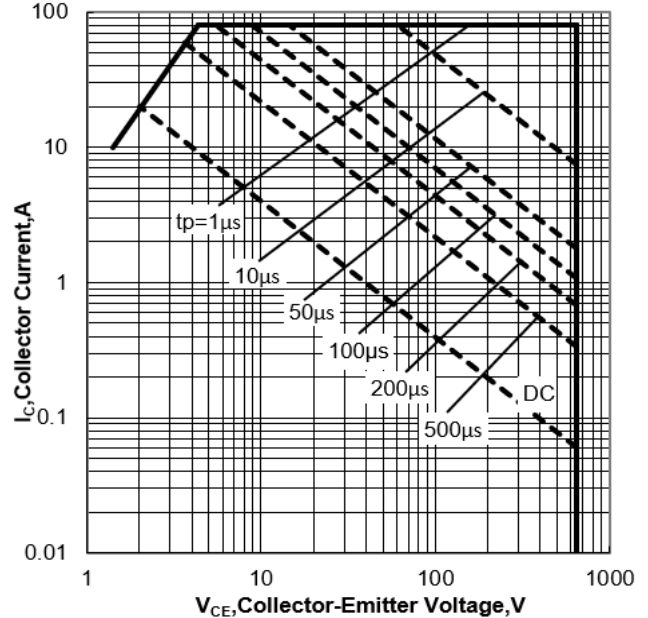


Figure 3. Forward Bias Safe Operating Area for TO247

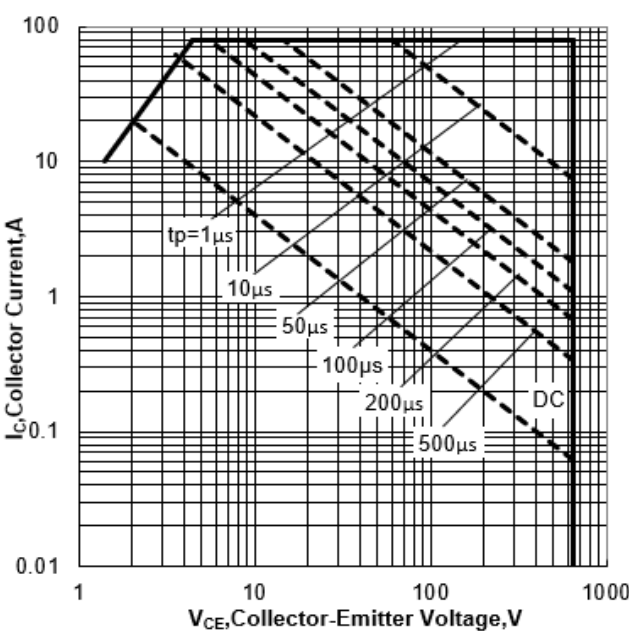


Figure 4. Power Dissipation vs Case Temperature for TO247

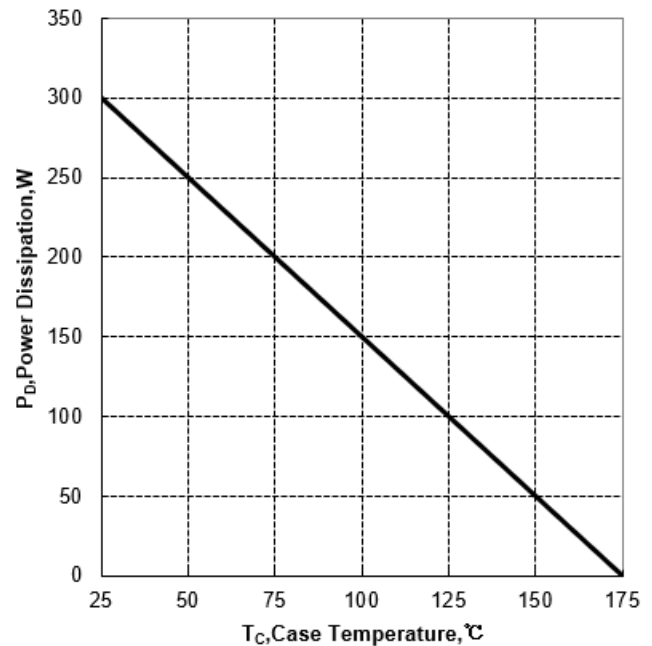


Figure 5. Power Dissipation vs Case Temperature for TO220/TO263

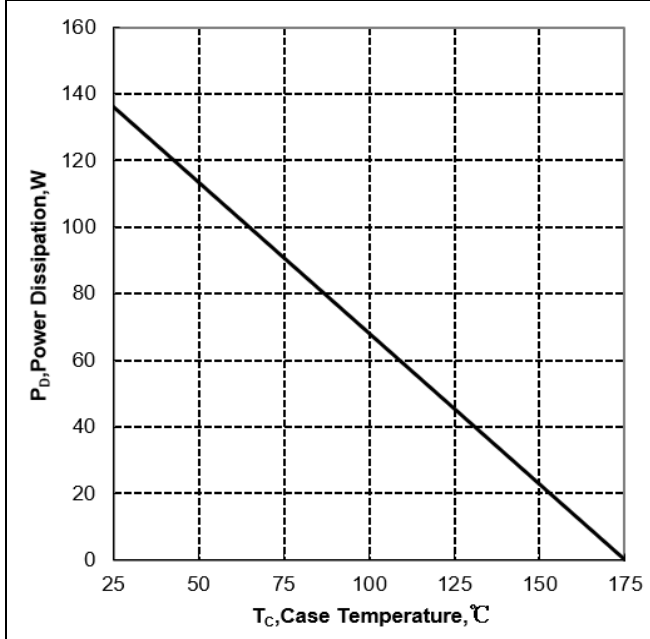


Figure 6. Power Dissipation vs Case Temperature for TO220F

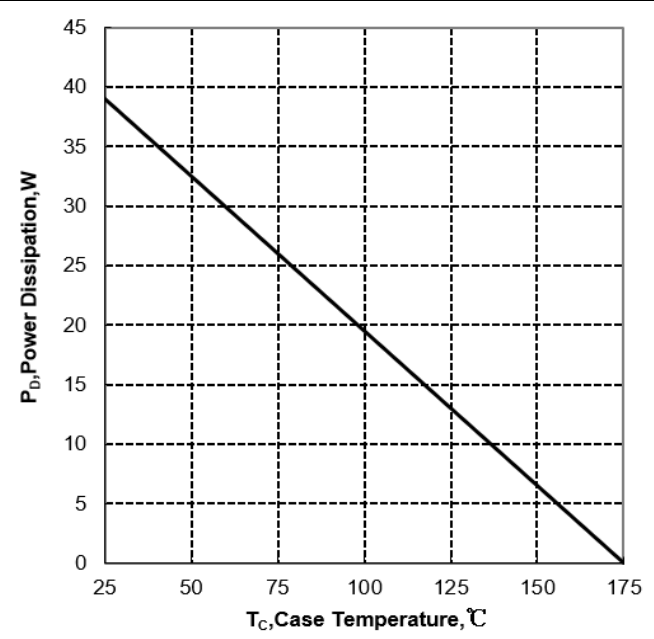


Figure 7. Collector Current vs Case Temperature for TO247/220/263

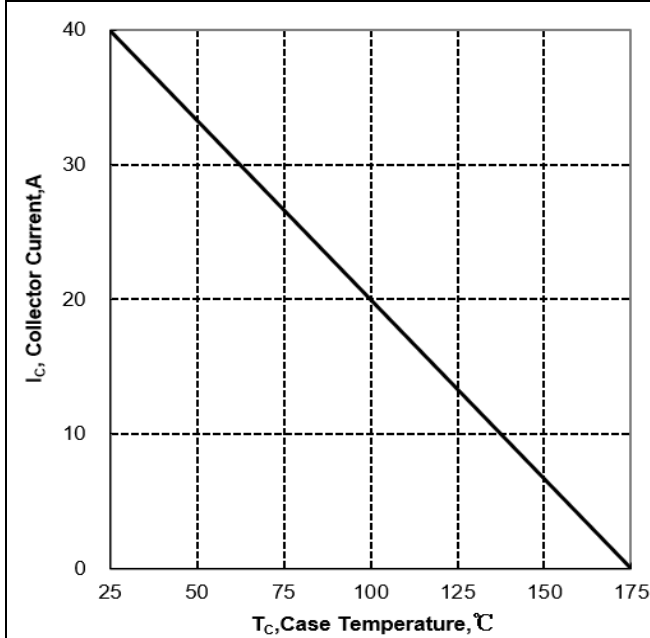


Figure 8. Collector Current vs Case Temperature for TO220F

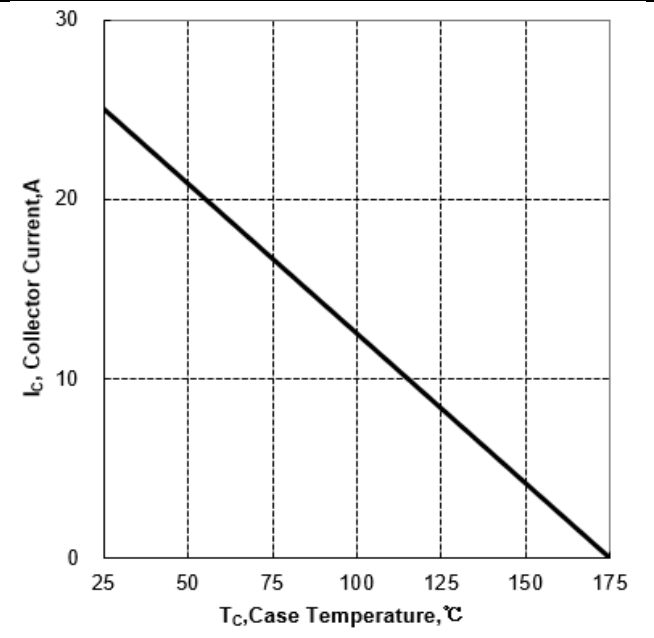


Figure 9. Typical Output Characteristics
($T_J=25^\circ\text{C}$)

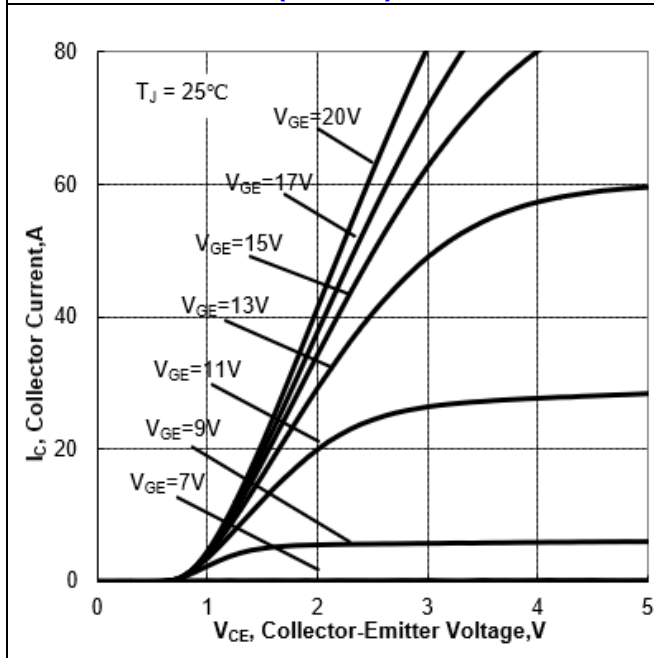


Figure 10. Typical Output Characteristics
($T_J=175^\circ\text{C}$)

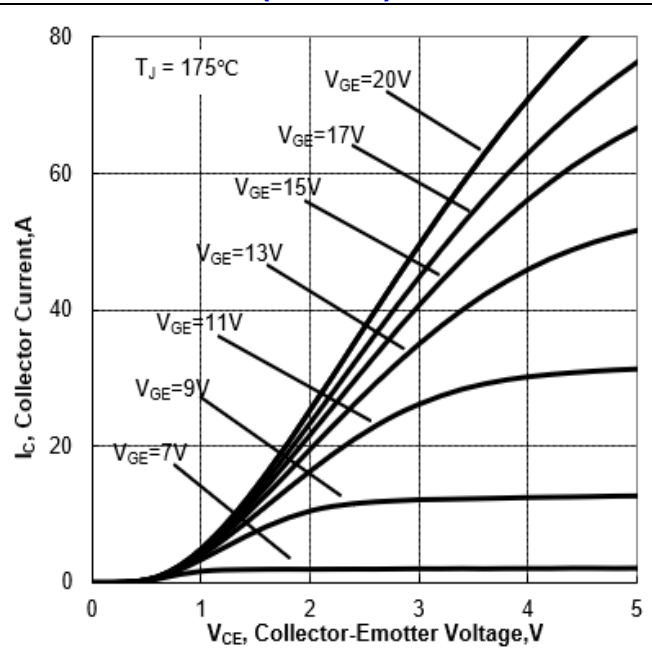


Figure 11. Typical Transfer Characteristics

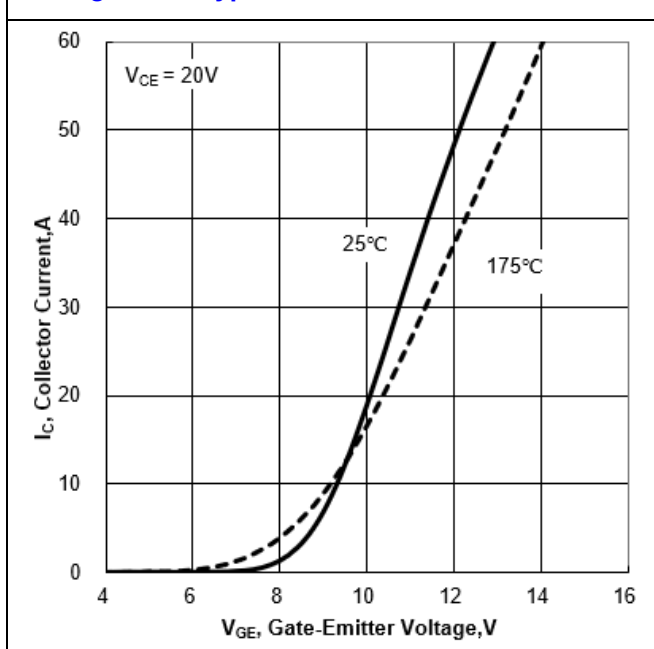


Figure 12. Typical Gate-Emitter Threshold Voltage vs Junction Temperature

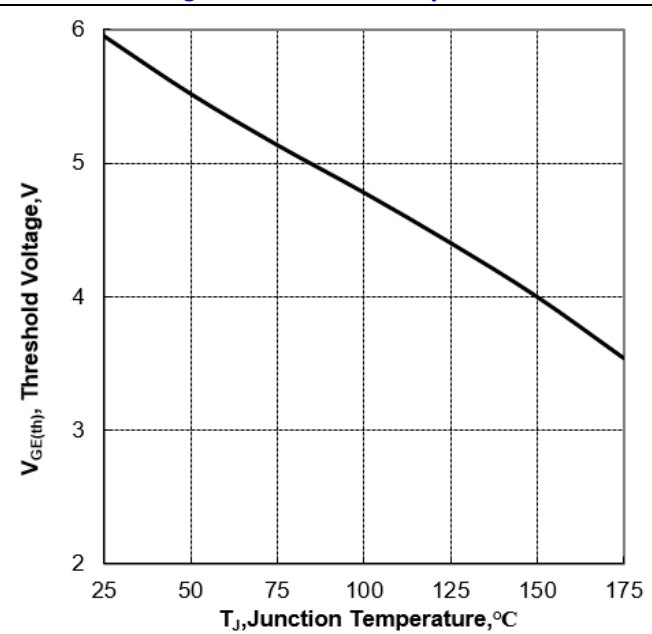


Figure 13. Typical Collector-Emitter Saturation Voltage vs Junction Temperature

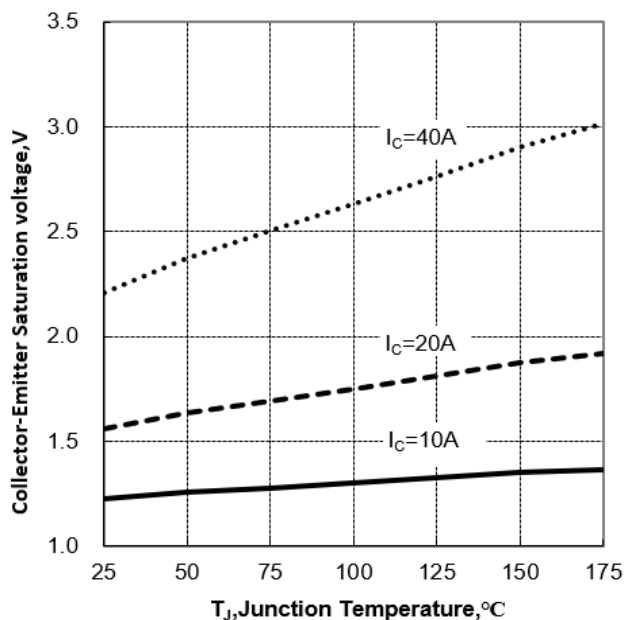


Figure 14. Typical Diode Forward Current vs Forward Voltage

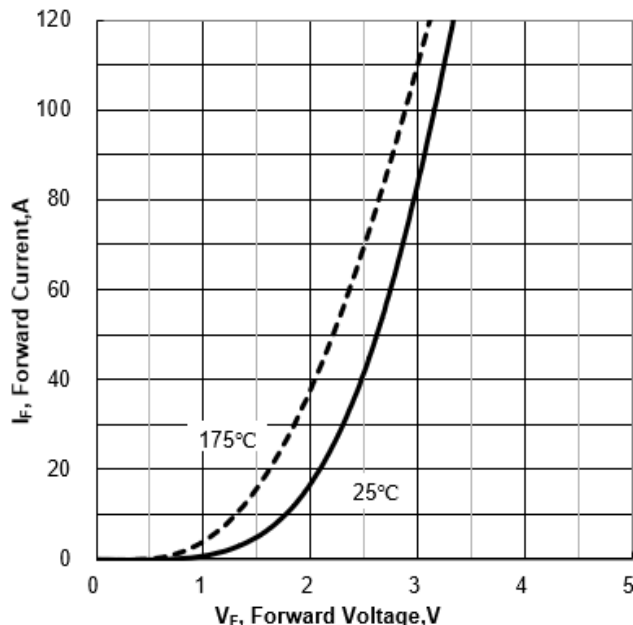


Figure 15. Typical Switching Times vs Gate Resistor ($T_J=25^\circ\text{C}$, $V_{CE}=400\text{V}$, $V_{GE}=15/0\text{V}$, $I_C=20\text{A}$)

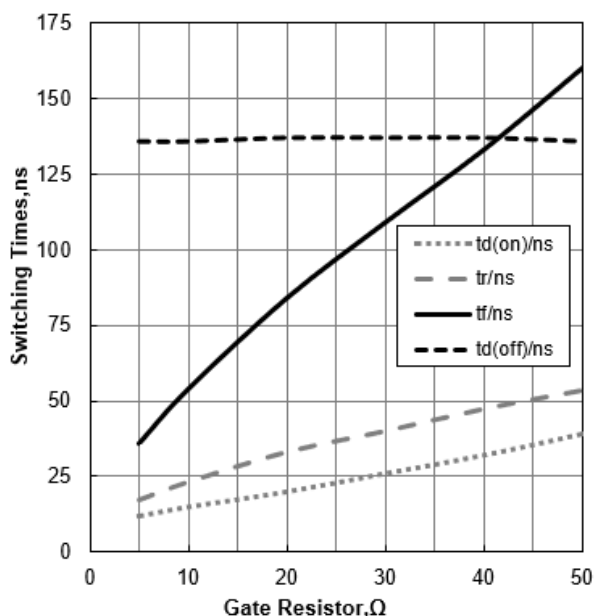


Figure 16. Typical Switching Energy vs Gate Resistor ($T_J=25^\circ\text{C}$, $V_{CE}=400\text{V}$, $V_{GE}=15/0\text{V}$, $I_C=20\text{A}$)

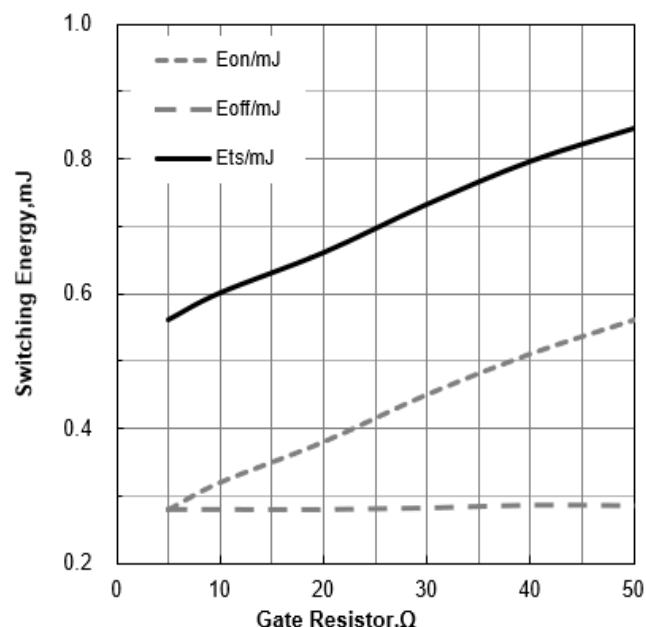


Figure 17. Typical Switching Times vs Junction Temperature ($V_{CE}=400V$, $V_{GE}=15/0V$, $I_C=20A$)

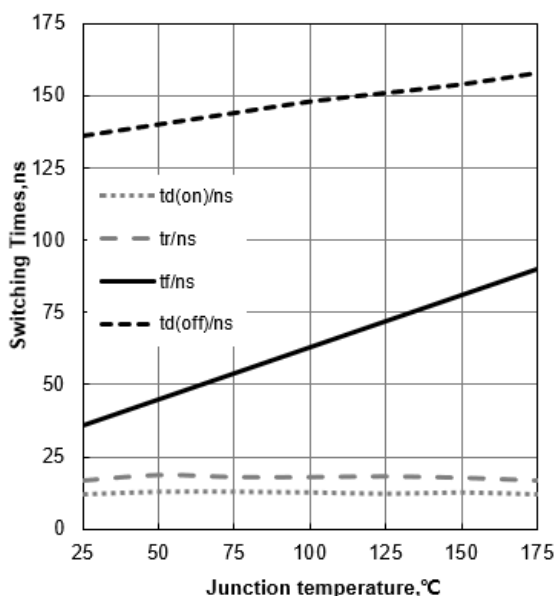


Figure 18. Typical Switching Energy vs Junction Temperature ($V_{CE}=400V$, $V_{GE}=15/0V$, $I_C=20A$)

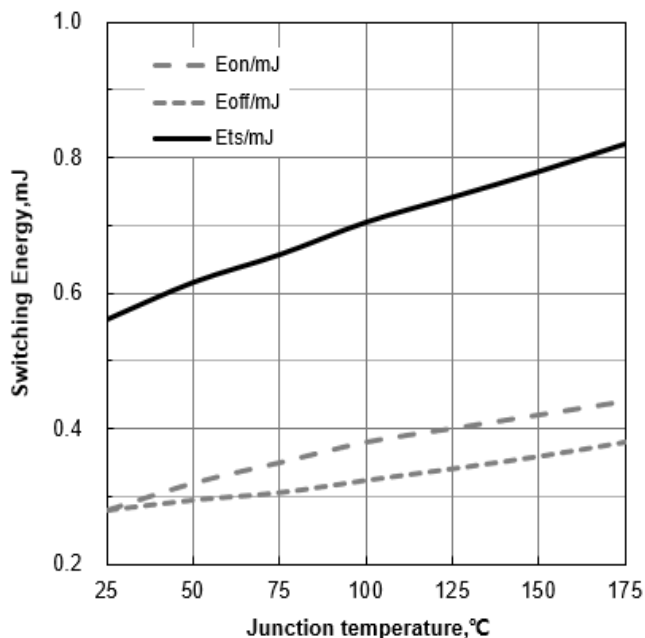


Figure 19. Typical Switching Times vs Collector Current ($T_J=25^\circ C$, $V_{CE}=400V$, $V_{GE}=15/0V$)

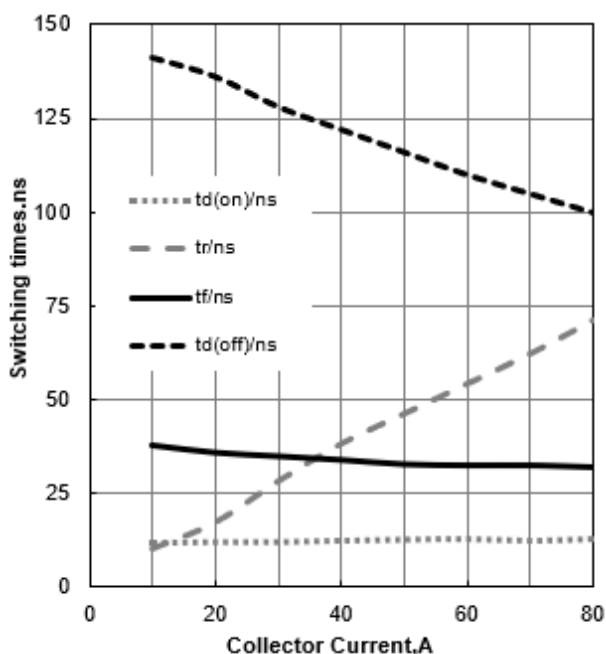


Figure 20. Typical Switching Energy vs Collector Current ($T_J=25^\circ C$, $V_{CE}=400V$, $V_{GE}=15/0V$)

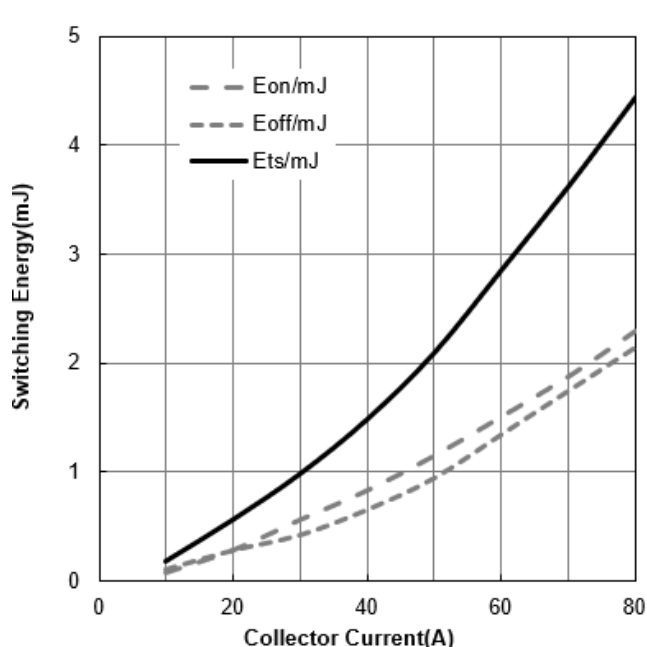


Figure 21. Typical Switching Times vs V_{CE}
($T_J=25^\circ\text{C}$, $V_{GE}=15/0\text{V}$, $I_C=20\text{A}$)

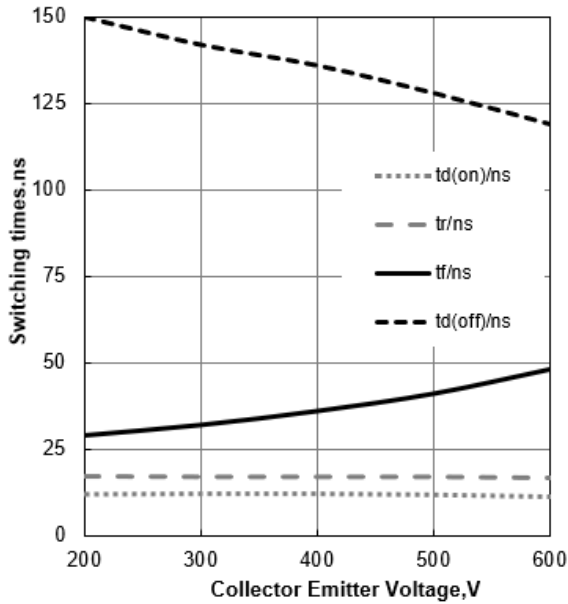


Figure 22. Typical Switching Energy vs V_{CE}
($T_J=25^\circ\text{C}$, $V_{GE}=15/0\text{V}$, $I_C=20\text{A}$)

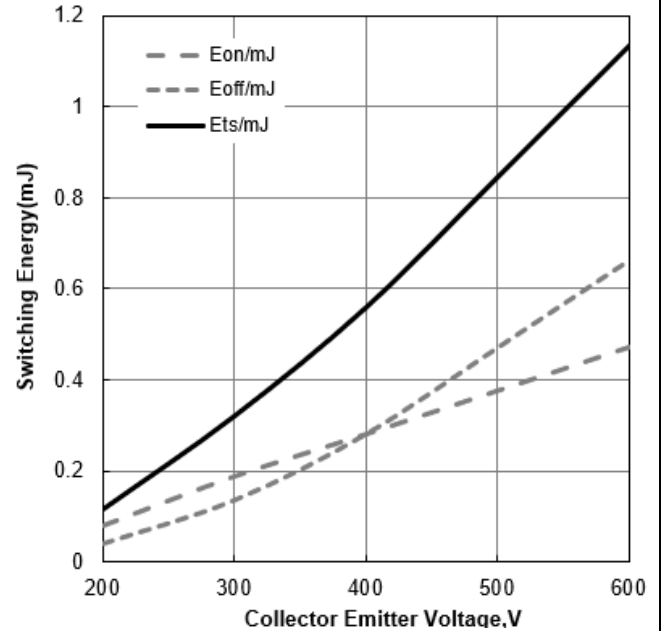


Figure 23. Typical Gate Charge

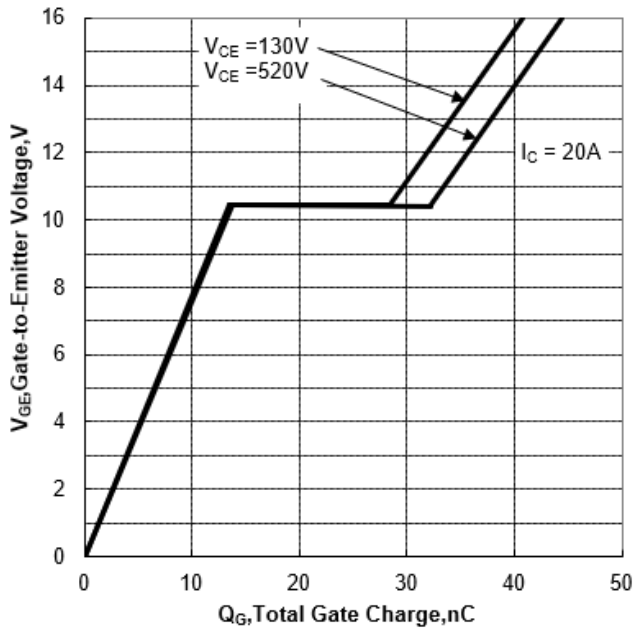


Figure 24. Typical Capacitance vs Collector-Emitter Voltage

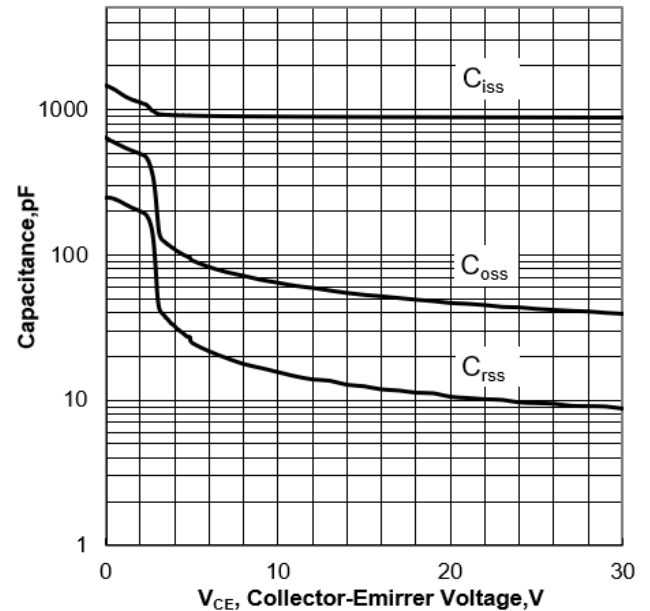


Figure 25. IGBT Transient Thermal Impedance vs Pulse Width(TO220/TO263)

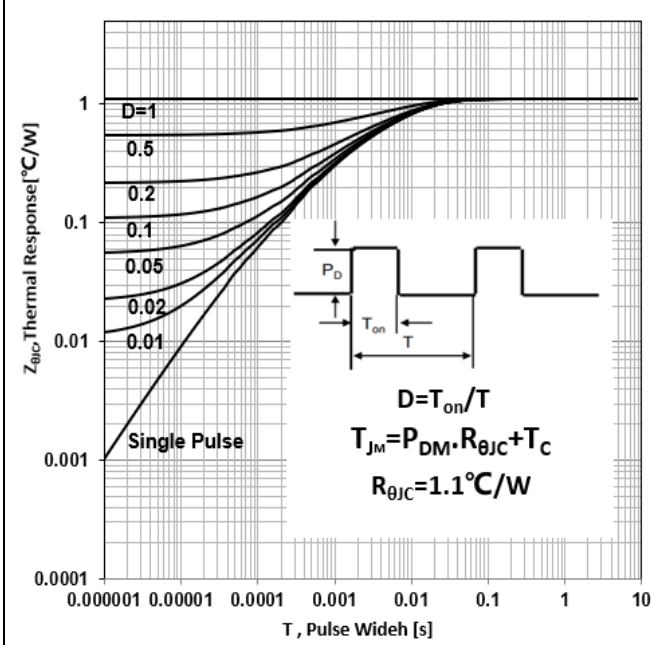


Figure 26. IGBT Transient Thermal Impedance vs Pulse Width(TO220F)

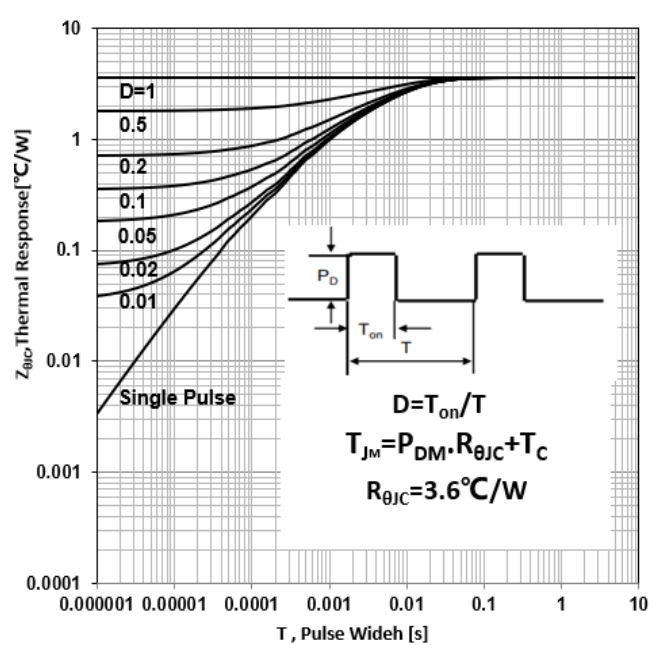


Figure 27. Diode Transient Thermal Impedance vs Pulse Width(TO220/TO263)

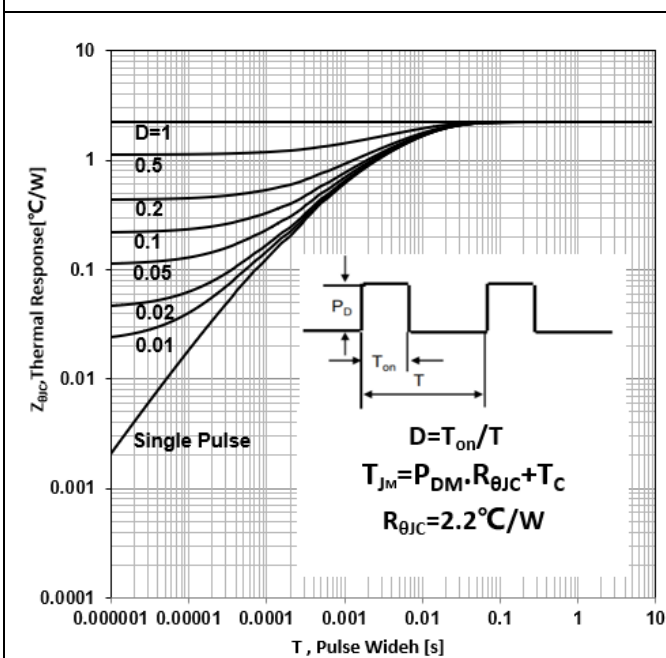


Figure 28. Diode Transient Thermal Impedance vs Pulse Width(TO220F)

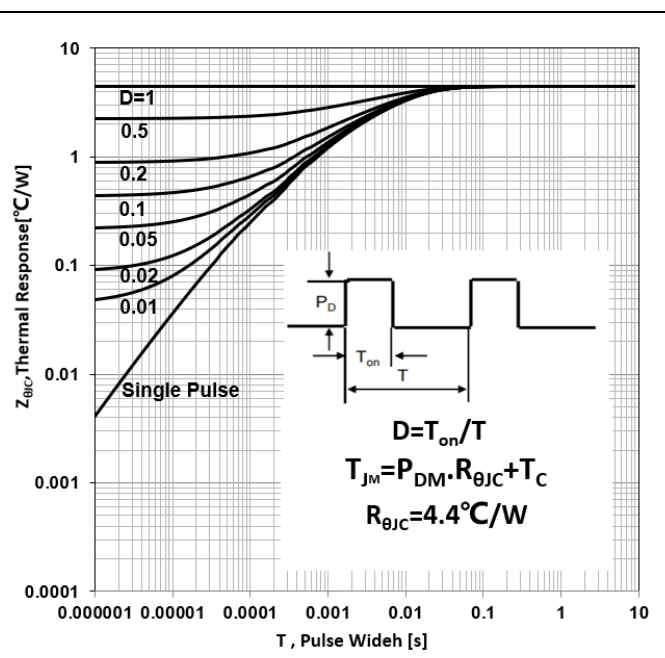


Figure 29. IGBT Transient Thermal Impedance vs Pulse Width(TO247)

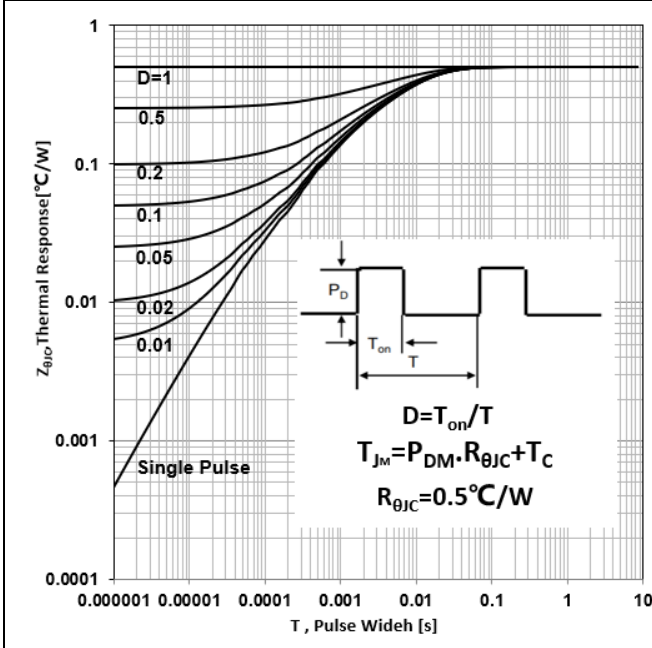
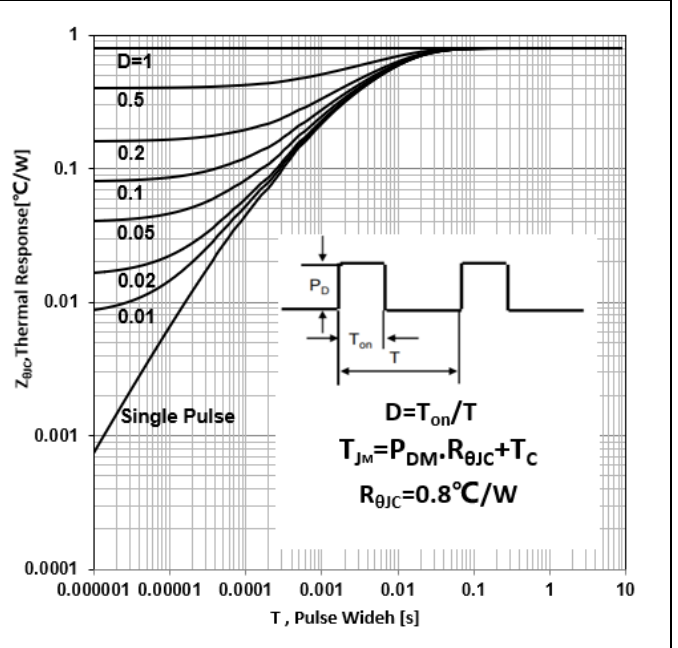


Figure 30. Diode Transient Thermal Impedance vs Pulse Width(TO247)



6. Test Circuit and Waveform

Figure 1. Inductive Switching Test Circuit

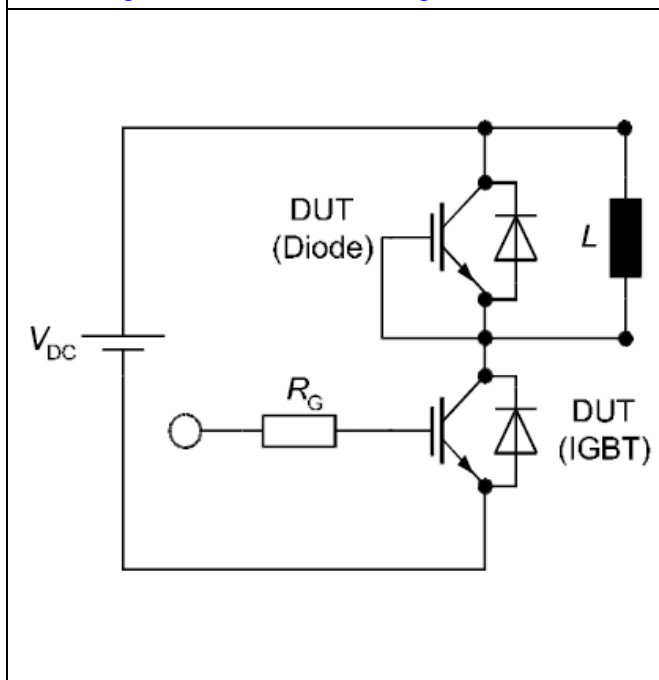


Figure 2. Definition of switching times

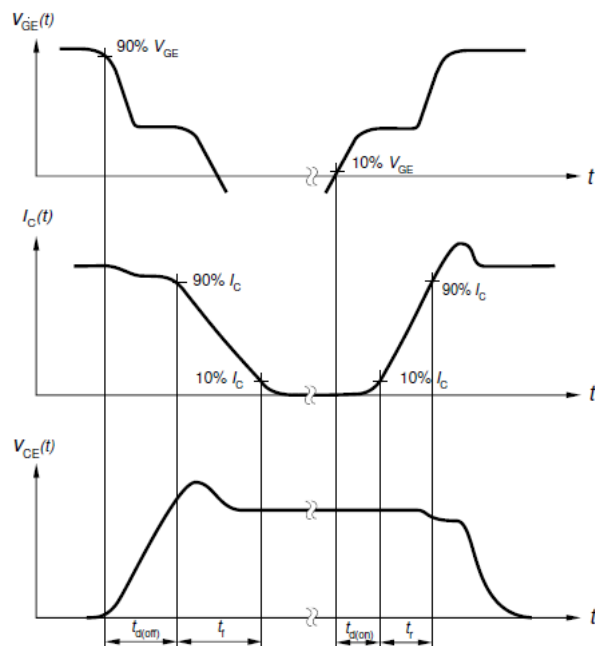


Figure 3. Definition of switching losses

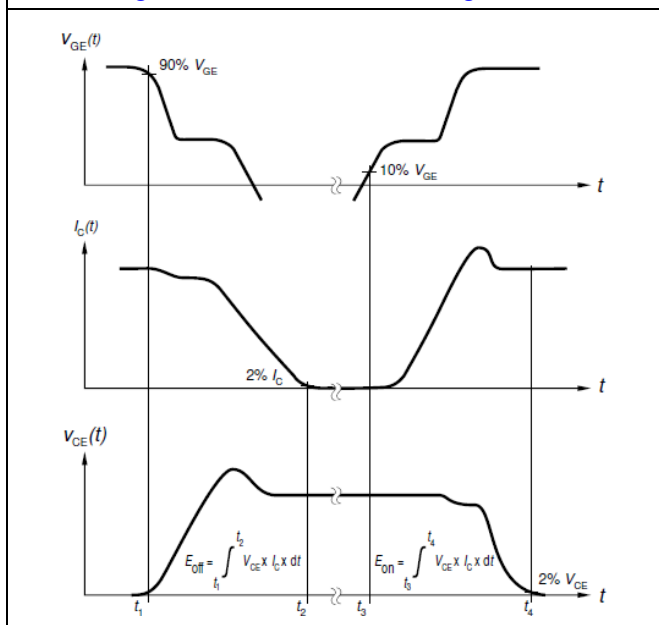
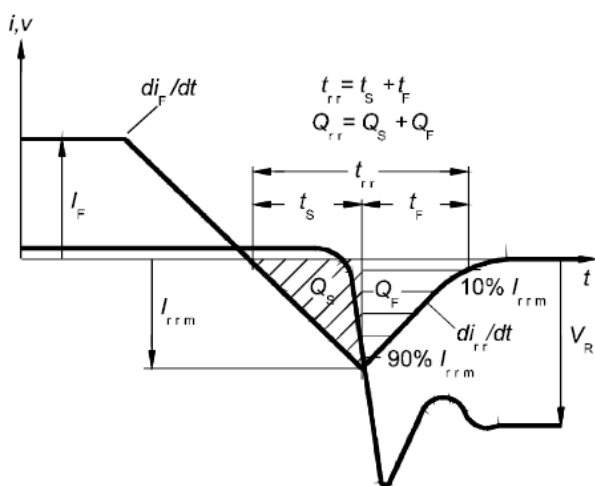
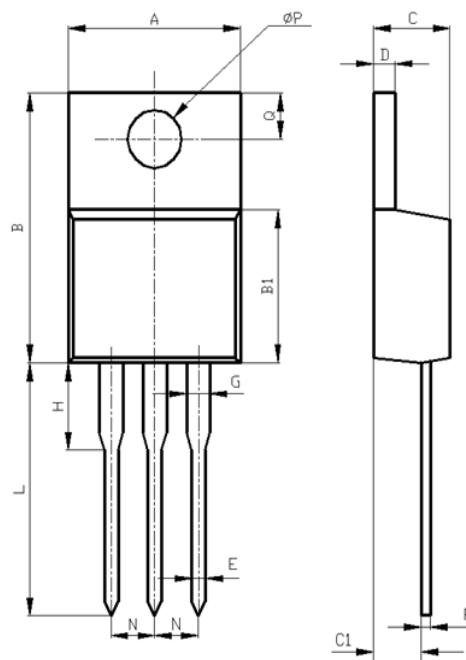


Figure 4. Definition of diode switching characteristics

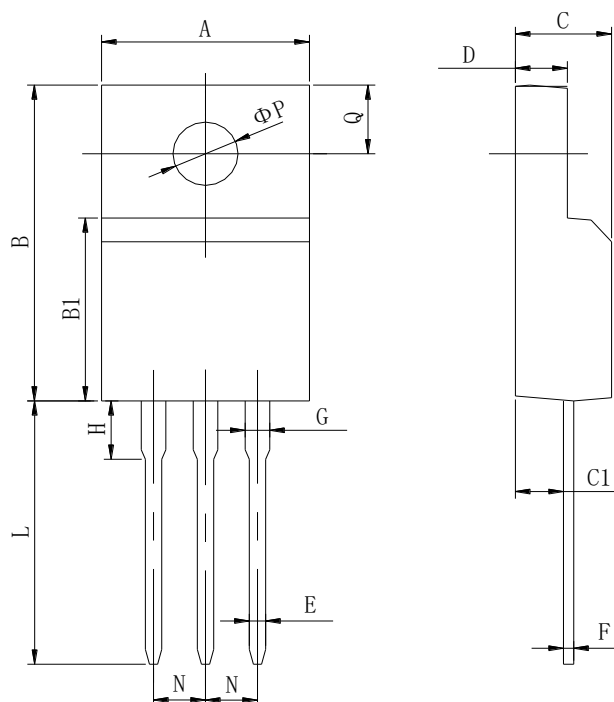


7. Package Description



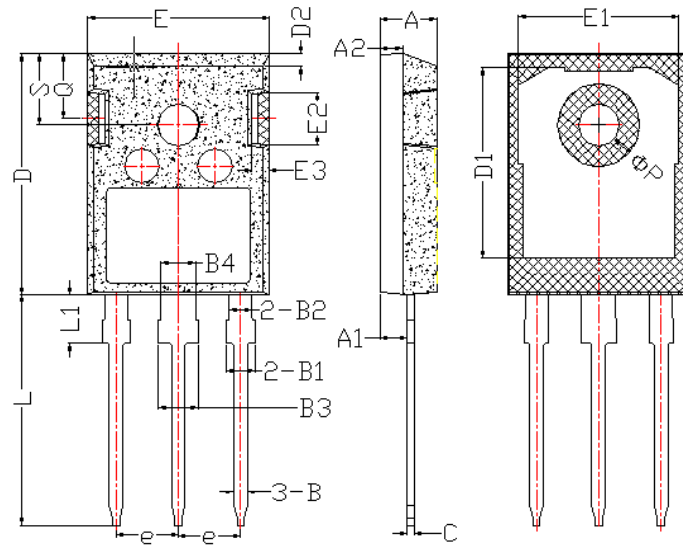
TO-220 Package

Items	Values(mm)	
	MIN	MAX
A	9.60	10.6
B	15.0	16.0
B1	8.90	9.50
C	4.30	4.80
C1	2.30	3.10
D	1.20	1.40
E	0.70	0.90
F	0.30	0.60
G	1.17	1.37
H	2.70	3.80
L	12.6	14.8
N	2.34	2.74
Q	2.40	3.00
Φ P	3.50	3.90



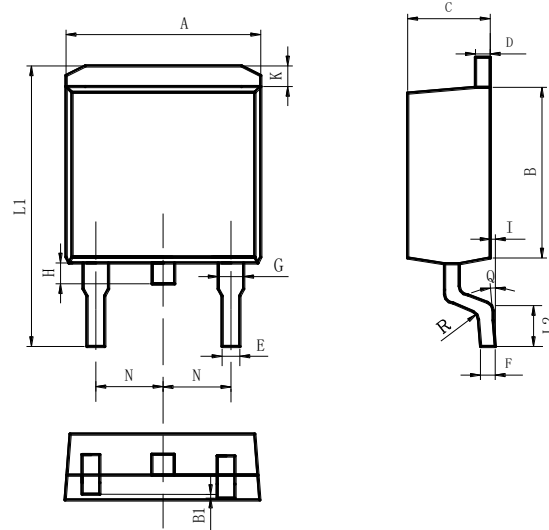
TO-220F Package

Items	Values(mm)	
	MIN	MAX
A	9.60	10.4
B	15.4	16.2
B1	8.90	9.50
C	4.30	4.90
C1	2.10	3.00
D	2.40	3.00
E	0.60	1.00
F	0.45	0.60
G	1.12	1.42
H	3.40	3.80
	1.60	2.90
L	12.0	14.0
N	2.34	2.74
Q	3.15	3.55
ΦP	2.90	3.30



TO-247 Package

Items	Values(mm)	
	MIN	MAX
A	4.90	5.16
A1	2.27	2.53
A2	1.85	2.11
B	1.07	1.33
B1	1.90	2.41
B2	1.75	2.15
B3	2.87	3.38
B4	2.87	3.13
C	0.55	0.68
D	20.82	21.10
D1	16.25	17.65
D2	1.05	1.35
E	15.70	16.03
E1	13.10	14.15
E2	3.68	5.10
E3	1.68	2.60
e	5.44	
L	19.80	20.31
L1	4.17	4.47
ΦP	3.50	3.70
Q	5.49	6.00
S	6.04	6.30



TO-263 Package

Items	Values(mm)	
	MIN	MAX
A	9.80	10.40
B	8.90	9.50
B1	0	0.10
C	4.40	4.80
D	1.16	1.37
E	0.70	0.95
F	0.30	0.60
G	1.07	1.47
H	1.30	1.80
K	0.95	1.37
L1	14.50	16.50
L2	1.60	2.30
I	0	0.2
Q	0°	8°
R	0.4	
N	2.39	2.69

NOTE:

1. Exceeding the maximum ratings of the device in performance may cause damage to the device, even the permanent failure, which may affect the dependability of the machine. Please do not exceed the absolute maximum ratings of the device when circuit designing.
2. When installing the heat sink, please pay attention to the torsional moment and the smoothness of the heat sink.
3. IGBTs is the device which is sensitive to the static electricity, it is necessary to protect the device from being damaged by the static electricity when using it.
4. Shanghai Belling reserves the right to make changes in this specification sheet and is subject to change without prior notice.

CONTACT:**上海贝岭股份有限公司**

地址：上海市宜山路 810 号

邮编：200233

联系方式：<https://www.belling.com.cn/contact.html>

Revision History:

BLG20T65FDLA Revision: 2023-10-31, Rev.5.0

Previous Revision

Revision	Date	Revision Date Subjects (major changes since last revision)
6.0	2023-11-17	(1) Product Code (2) CONTACT